Unit: mm

#### TOSHIBA Transistor Silicon NPN Epitaxial Type

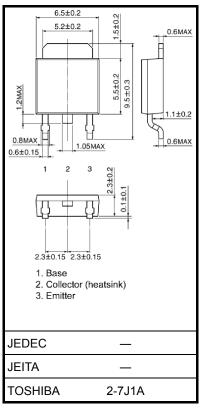
# 2SC6000

# High Speed Switching Applications DC-DC Converter Applications

- High DC current gain:  $h_{FE} = 250 \text{ to } 400 \text{ (IC} = 2.5 \text{ A)}$
- Low collector-emitter saturation:  $V_{CE (sat)} = 0.18 \text{ V (max)}$
- High speed switching:  $t_f = 13 \text{ ns (typ)}$

#### **Absolute Maximum Ratings (Ta = 25°C)**

Characteristics		Symbol	Rating	Unit	
Collector-base voltage		$V_{CBO}$	120	V	
Collector-emitter voltage		V <sub>CEX</sub>	120	V	
Collector-emitter voltage		V <sub>CEO</sub>	50	V	
Emitter-base voltage		V <sub>EBO</sub>	6	V	
Collector current	DC	IC	7.0	Α	
	Pulse	I <sub>CP</sub>	10.0		
Base current		ΙΒ	0.5	Α	
Collector power dissipation	Tc = 25°C	P <sub>C</sub>	20	W	
Junction temperature		Tj	150	°C	
Storage temperature range		T <sub>stg</sub>	−55 to 150	°C	



Weight: 0.36 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high

temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

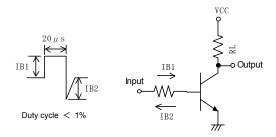
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).



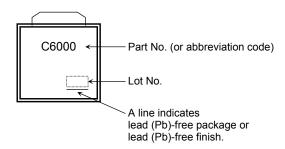
### **Electrical Characteristics (Ta = 25°C)**

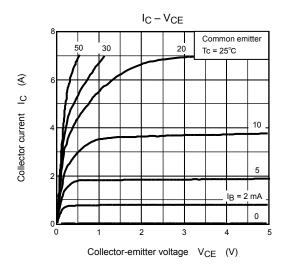
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit	
Collector cut-off current		I <sub>CBO</sub>	V <sub>CB</sub> = 120 V, I <sub>E</sub> = 0	_	_	100	nA	
Emitter cut-off current		I <sub>EBO</sub>	V <sub>EB</sub> = 6 V, I <sub>C</sub> = 0	_	_	100	nA	
Collector-emitter breakdown voltage		V (BR) CEO	I <sub>C</sub> = 10 mA, I <sub>B</sub> = 0	50	_	_	V	
DC current gain		h <sub>FE (1)</sub>	V <sub>CE</sub> = 2 V, I <sub>C</sub> = 1 mA	160	_	_		
		h <sub>FE (2)</sub>	V <sub>CE</sub> = 2 V, I <sub>C</sub> = 2.5 A	250	_	400		
Collector emitter saturation voltage		V <sub>CE (sat)</sub>	I <sub>C</sub> = 2.5 A, I <sub>B</sub> = 83 mA	_	_	0.18	V	
Base-emitter saturation voltage		V <sub>BE (sat)</sub>	I <sub>C</sub> = 2.5 A, I <sub>B</sub> = 83 mA	_	_	1.10	V	
Switching time	Rise time	t <sub>r</sub>	See Figure 1 circuit diagram $V_{CC} \simeq 20 \text{ V, R}_L = 8.0 \ \Omega$ $I_{B1} = 83 \text{ mA, } I_{B2} = -166 \text{ mA}$	_	45	_		
	Storage time	t <sub>stg</sub>		_	450	_	ns	
	Fall time	t <sub>f</sub>		_	13	_		

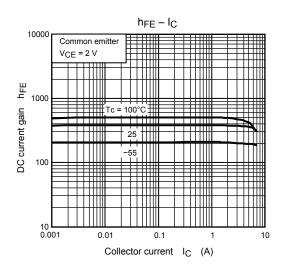
Figure 1 Switching Time Test Circuit & Timing Chart

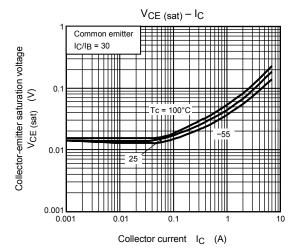


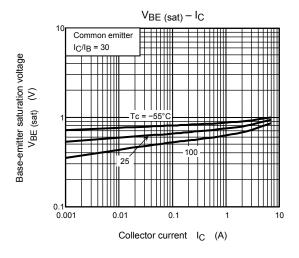
## Marking

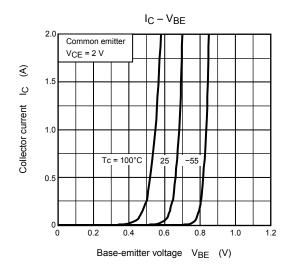


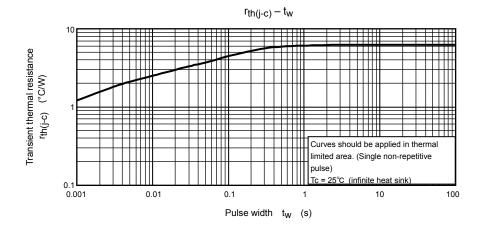


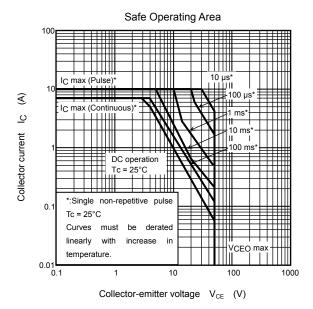












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